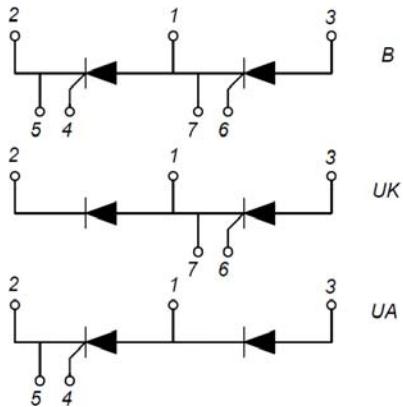


## PRODUCT FEATURES

- Electrically Isolated by DBC Ceramic
- High Surge Current Capability
- Low Inductance Package

## APPLICATIONS

- DC Motor Control and Drives
- Battery Charges ,Heater controls,Light dimmers
- Static switches



## **MAXIMUM VOLTAGE RATINGS**

$T_c = 25^\circ\text{C}$  unless otherwise specified

Module Type			$V_{RRM}/V_{DRM}$	$V_{RSM}$	Unit
MMK200S080B	MMK200S080UK	MMK200S080UA	800	900	V
MMK200S120B	MMK200S120UK	MMK200S120UA	1200	1300	
MMK200S140B	MMK200S140UK	MMK200S140UA	1400	1500	
MMK200S160B	MMK200S160UK	MMK200S160UA	1600	1700	
MMK200S180B	MMK200S180UK	MMK200S180UA	1800	1900	
MMK200S200B	MMK200S200UK	MMK200S200UA	2000	2100	
MMK200S220B	MMK200S220UK	MMK200S220UA	2200	2300	

## **ABSOLUTE MAXIMUM RATINGS (Thyristor)**

Symbol	Parameter/Test Conditions		Values	Unit
$I_{T(AV)}$	Average On-State Current	Single phase, half wave, 180° conduction, $T_c = 80^\circ\text{C}$	200	A
$I_{T(RMS)}$	R.M.S. On-State Current		310	
$I_{TSM}$	Non-Repetitive Surge On-State Current	1/2 cycle, 50/60HZ, peak value, $T_c = 45^\circ\text{C}$		4000/4300
$I^2t$	$I^2t$ (For Fusing)	1/2 cycle, 50/60HZ, peak value, $T_c = 45^\circ\text{C}$		800/767.3
$T_J$	Junction Temperature(Thyristor)			KA <sup>2</sup> S
				-40 to +125 °C

## **ABSOLUTE MAXIMUM RATINGS (Diode)**

Symbol	Parameter/Test Conditions		Values	Unit
$I_{F(AV)}$	Average Forward Current	Single phase, half wave, 180° conduction, $T_c = 95^\circ\text{C}$	200	A
$I_{F(RMS)}$	R.M.S. Forward Current		310	
$I_{FSM}$	Non-Repetitive Surge Forward Current	1/2 cycle, 50/60HZ, peak value, $T_c = 45^\circ\text{C}$		6800/7300
$I^2t$	For Fusing	1/2 cycle, 50/60HZ, peak value, $T_c = 45^\circ\text{C}$		231.2/221.1 KA <sup>2</sup> S
$T_J$	Junction Temperature(Diode)			-40 to +150 °C

**ELECTRICAL CHARACTERISTICS (Thyristor)** $T_C=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit	
$I_{DRM}$	Maximum Peak Off-State Current	$V_D = V_{DRM}, T_J = 125^\circ\text{C}$			25	mA	
$I_{RRM}$	Maximum Peak Reverse Current	$V_R = V_{RRM}, T_J = 125^\circ\text{C}$			25		
$V_{TM}$	Maximum on-state voltage drop	$I_{TM}=500\text{A}, t_d=10\text{ ms, half sine}$			1.75	V	
$V_{TO}$	For power-loss calculations only	$T_J = 125^\circ\text{C}$			0.80	V	
$r_T$					2.0	$\text{m}\Omega$	
$V_{GT}$	Max. required DC gate voltage to trigger	$V_A=6\text{V}, R_A=1\Omega, T_J = -40^\circ\text{C}$			4.0	V	
		$V_A=6\text{V}, R_A=1\Omega$			1.0		
		$V_A=6\text{V}, R_A=1\Omega, T_J = 125^\circ\text{C}$			1.7		
$I_{GT}$	Max. required DC gate current to trigger	$V_A=6\text{V}, R_A=1\Omega, T_J = -40^\circ\text{C}$			270	mA	
		$V_A=6\text{V}, R_A=1\Omega$			75		
		$V_A=6\text{V}, R_A=1\Omega, T_J = 125^\circ\text{C}$			150		
					80		
$V_{GD}$	Max. required DC gate voltage not to trigger, $V_D = V_{DRM}, T_J = 125^\circ\text{C}$				0.25	V	
$I_{GD}$	Max. required DC gate current not to trigger, $V_D = V_{DRM}, T_J = 125^\circ\text{C}$				6	mA	
$I_H$	Maximum holding current				100	200	mA
$I_L$	Maximum latching current				200	400	mA
$P_{GM}$	Maximum peak gate power				12	W	
$P_{G(AV)}$	Maximum average gate power				3.0		
$I_{GM}$	Maximum peak gate current				3.0	A	
$-V_{GM}$	Maximum peak negative gate voltage				10	V	
$dv/dt$	Critical Rate of Rise of Off-State Voltage, $T_J=125^\circ\text{C}$ , exponential to 67% rated $V_{DRM}$				1000	$\text{V}/\mu\text{s}$	
$di/dt$	Max. Rate of Rise of Turned-on Current, $T_J = 125^\circ\text{C}, I_{TM}=500\text{A}$ , rated $V_{DRM}$				150	$\text{A}/\mu\text{s}$	

**ELECTRICAL CHARACTERISTICS (Diode)**

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$I_{RM}$	Maximum Reverse Leakage Current	$V_R = V_{RRM}$			0.5	mA
		$V_R = V_{RRM}, T_J = 125^\circ\text{C}$			10	
$V_F$	Forward Voltage Drop	$I_F=500\text{A}$			1.5	V
$V_{TO}$	For power-loss calculations only , $T_J = 125^\circ\text{C}$				0.9	V
					1.0	$\text{m}\Omega$

**MODULE CHARACTERISTICS** $T_C=25^\circ\text{C}$  unless otherwise specified

$T_J$	Junction Temperature		-40 to +125	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range		-40 to +125	$^\circ\text{C}$
$V_{ISO}$	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), $t=1\text{ minute}$	3000	V
<b>Torque</b>	to heatsink	Recommended (M6)	3~5	N.m
<b>Torque</b>	to terminal	Recommended (M6)	3~5	N.m
$R_{th(J-C)}$	Junction-to-Case Thermal Resistance(Per Thyristor/Per Diode)		0.12/0.14	K /W
<b>Weight</b>			160	g

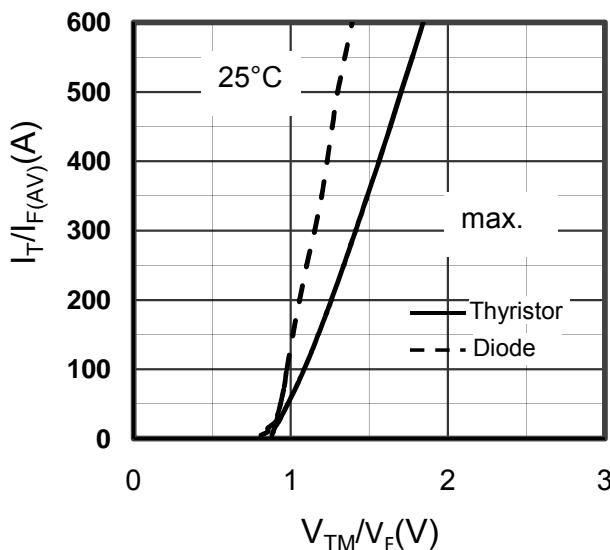


Figure1. Forward Voltage Drop vs Forward Current

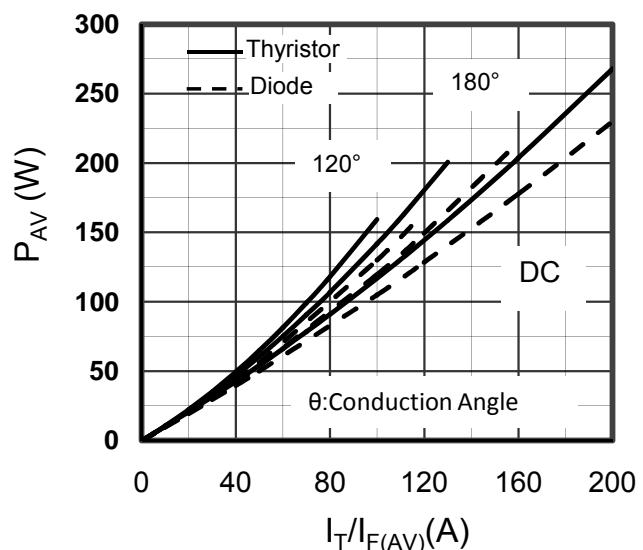
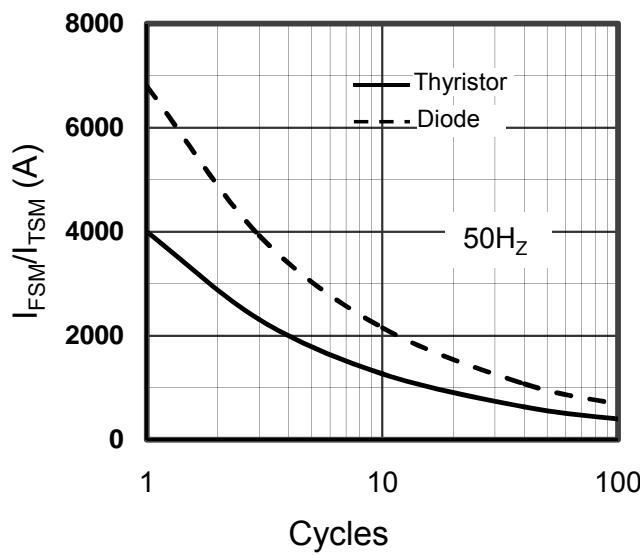
Figure2. Power dissipation vs.  $I_T/I_{F(AV)}$ 

Figure3. Diode and SCR Max Non-Repetitive Surge

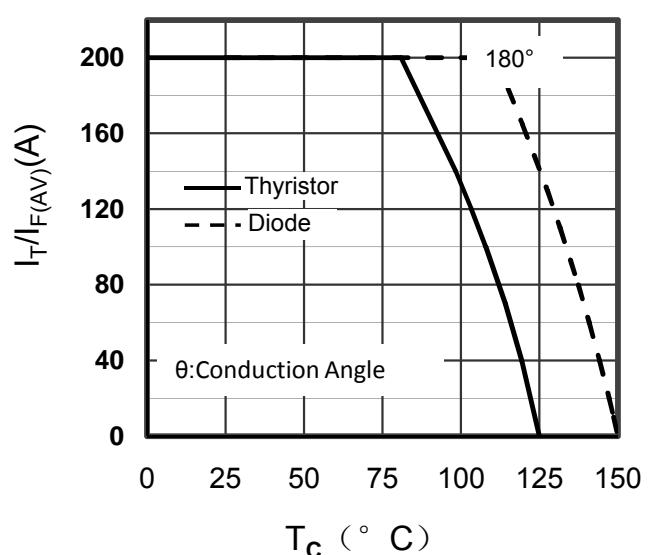
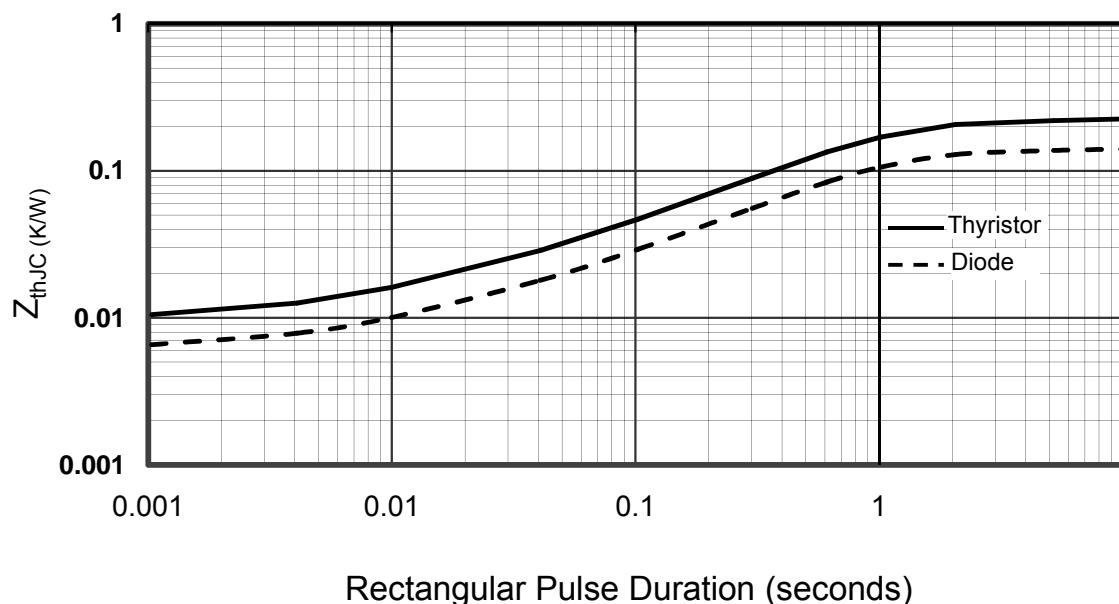
Figure4. Diode  $I_{F(AV)}$  and SCR  $I_{T(AV)}$ vs. $T_C$ 

Figure5. Transient Thermal Impedance of Diode and SCR

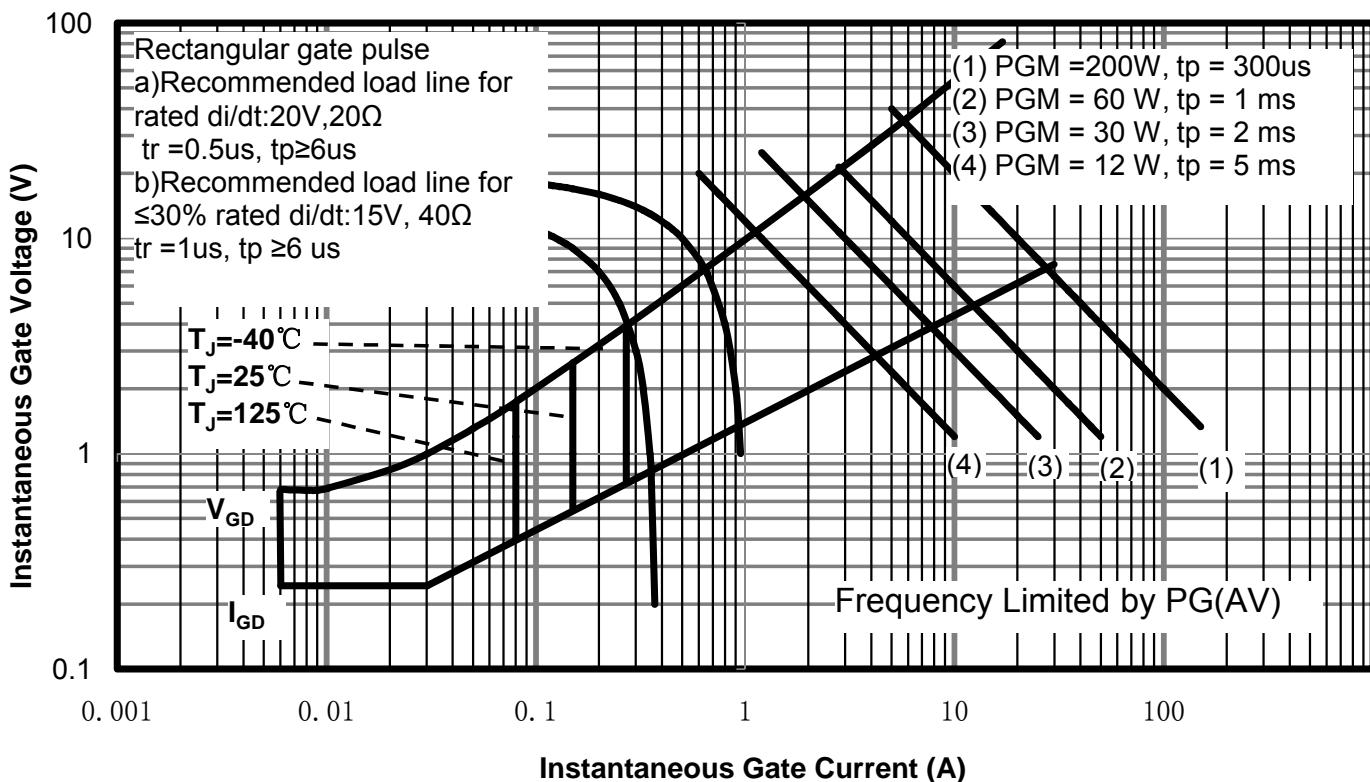
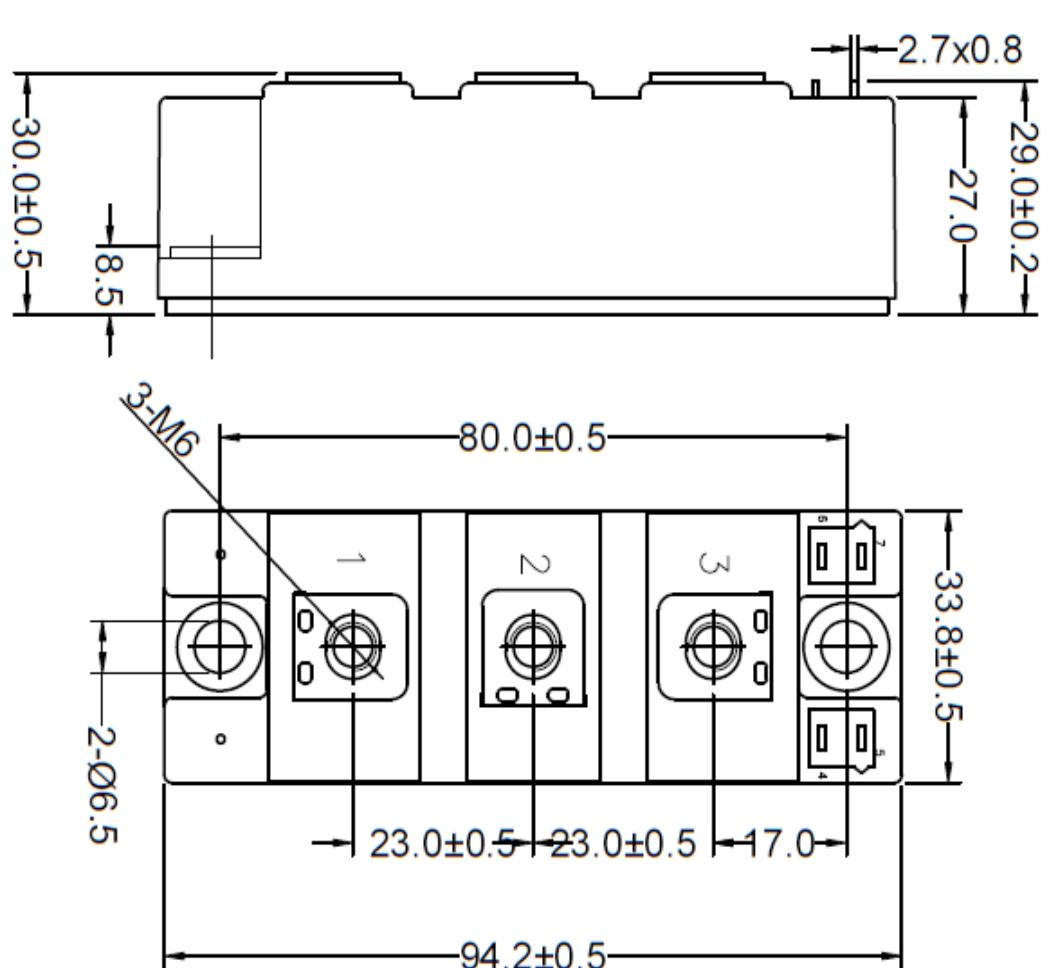


Figure 6. SCR Gate Characteristics



Dimensions in Millimeters  
Figure 7. Package Outline